SN74F323 8-BIT UNIVERSAL SHIFT-STORAGE REGISTER WITH SYNCHRONOUS CLEAR AND 3-STATE OUTPUTS

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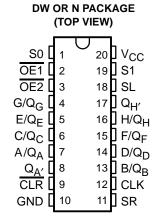
Four Modes of Operation:

Hold (Store)
Shift Right
Shift Left
Load Data

- Operates With Outputs Enabled or at High Impedance
- 3-State Outputs Drive Bus Lines Directly
- Can Be Cascaded for N-Bit Word Lengths
- Synchronous Clear
- Applications:

Stacked or Push-Down Registers Buffer Storage Accumulator Registers

 Package Options Include Plastic Small-Outline Packages and Standard Plastic 300-mil DIPs



description

This 8-bit universal register features multiplexed I/O ports to achieve full 8-bit data handling in a single 20-pin package. Two function-select (S0, S1) and two output-enable (OE1, OE2) inputs can be used to choose the modes of operation listed in the function table.

Synchronous parallel loading is accomplished by taking both S0 and S1 high. This places the 3-state outputs in a high-impedance state and permits data that is applied on the I/O ports to be clocked into the register. Reading out of the register can be accomplished while the outputs are enabled in any mode. Clearing occurs synchronously when the clear (CLR) input is low. Taking either OE1 or OE2 high disables the outputs but this has no effect on clearing, shifting, or storage of data.

The SN74F323 is characterized for operation from 0°C to 70°C.

FUNCTION TABLE

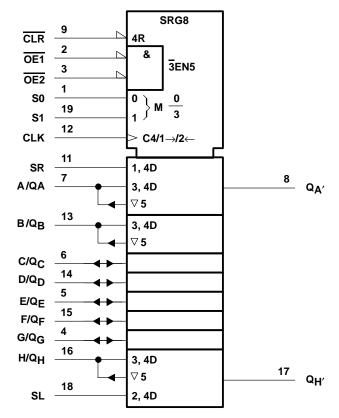
MODE				INP	UTS				I/O PORTS						OUTPUTS			
	CLR	S1	S0	OE1†	OE2†	CLK	SL	SR	A/Q _A	B/Q _B	C/QC	D/QD	E/Q _E	F/Q _F	G/Q _G	H/Q _H	$Q_{\mathbf{A}'}$	$Q_{H'}$
Clear	L	Χ	L	L	L	1	Х	Х	L	L	L	L	L	L	L	L	L	L
	L	L	Χ	L	L	1	Х	Χ	L	L	L	L	L	L	L	L	L	L
	L	Н	Н	Х	Χ	1	Х	Χ	Х	Χ	Χ	Χ	Χ	Χ	Χ	Χ	L	L
Hold	Н	L	L	L	L	Х	Х	Х	Q _{A0}	Q _{B0}	Q _{C0}	Q _{D0}	Q _{E0}	Q _{F0}	Q _{G0}	Q _{H0}	Q _{A0}	Q _{H0}
Hold	Н	Χ	Χ	L	L	L	Χ	Χ	Q _{A0}	Q_{B0}	Q_{C0}	Q_{D0}	Q_{E0}	Q _{F0}	Q_{G0}	Q _{H0}	Q _{A0}	Q _{H0}
Shift	Н	L	Н	L	L	1	Х	Н	Н	Q _{An}	Q _{Bn}	Q _{Cn}	Q _{Dn}	Q _{En}	Q _{Fn}	Q _{Gn}	Н	QGn
Right	Н	L	Н	L	L	1	Χ	L	L	Q_{An}	Q_{Bn}	Q_{Cn}	Q_{Dn}	Q_{En}	Q_{Fn}	Q_{Gn}	L	Q _{Gn}
Shift	Н	Н	L	L	L	1	Н	Χ	Q _{Bn}	Q _{Cn}	Q _{Dn}	Q _{En}	Q _{Fn}	QGn	Q _{Hn}	Н	Q _{Bn}	Н
Left	Н	Η	L	L	L	1	L	Χ	Q _{Bn}	Q_{Cn}	Q_{Dn}	Q_{En}	Q_{Fn}	Q_{Gn}	Q_{Hn}	L	Q _{Bn}	L
Load	Н	Н	Н	Х	Х	1	Х	Χ	а	b	С	d	е	f	g	h	а	h

NOTE: a...h = the level of the steady-state input at inputs A through H, respectively. These data inputs are loaded into the flip-flops while the flip-flop outputs are isolated from the I/O terminals.



[†] When one or both output-enable inputs are high the eight I/O terminals are disabled to the high-impedance state; however, sequential operation or clearing of the register is not affected.

logic symbol†

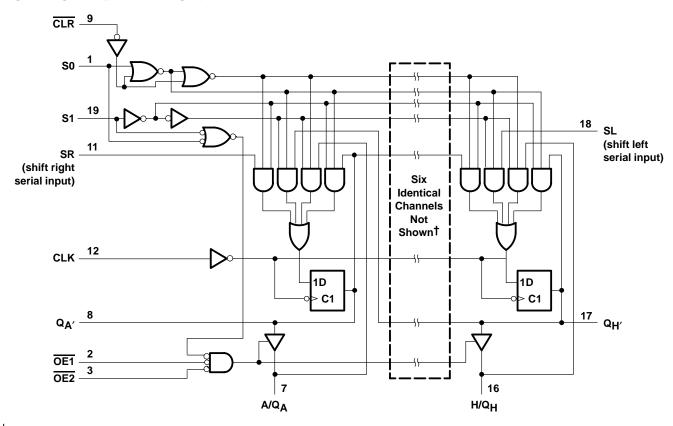


[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



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logic diagram (positive logic)



† I/O ports not shown: B/QB (13), C/QC (6), D/QD (14), E/QE (5), F/QF (15), and G/QG (4).

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V _{CC}	
Input current range	
Voltage range applied to any output in the disabled or power-off state	
Voltage range applied to any output in the high state	\dots -0.5 V to V _{CC}
Current into any output in the low state: Q _{A'} or Q _{H'}	40 mA
Q _A thru Q _H	48 mA
Operating free-air temperature range	0° C to 70° C
Storage temperature range	65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input voltage ratings may be exceeded provided the input current ratings are observed.

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recommended operating conditions

			MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	٧	
VIH	High-level input voltage	2			V	
VIL	Low-level input voltage			0.8	V	
ΙK	Input clamp current			-18	mA	
la	High-level output current	QA' or QH'			- 1	mA
ЮН	nigh-level output current			-3	IIIA	
lOL	Low-level output current	Q _A , or Q _H ,			20	mA
	Low-level output current			24	IIIA	
T _A	Operating free-air temperature				70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		1	TEST CONDITIONS				UNIT
VIK		$V_{CC} = 4.5 \text{ V},$	I _I = -18 mA			-1.2	V
VOH	Q _A ' or Q _H '		I _{OH} = – 1 mA	2.5	3.4		
	Q _A thru Q _H	V _{CC} = 4.5 V	$I_{OH} = -1 \text{ mA}$	2.5	3.4		V
	QA IIII QH		$I_{OH} = -3 \text{ mA}$	2.4	3.3		V
	Any output	$V_{CC} = 4.75 V$,	$V_{CC} = 4.75 \text{ V},$ $I_{OH} = -1 \text{ mA to } -3 \text{ mA}$]
V	Q _{A′} or Q _{H′}	V _{CC} = 4.5 V	I _{OL} = 20 mA		0.3	0.5	V
VOL	Q _A thru Q _H	vCC = 4.5 v	I _{OL} = 24 mA		0.35	0.5	V
	A thru H	V00 - 5 5 V	V _I = 5.5 V			1	mA
l _l	Any other	V _{CC} = 5.5 V	V _I = 7 V			0.1	IIIA
ıt	A thru H	V _{CC} = 5.5 V,	V _I =27'Y' v			70	^
¹IH [‡]	Any other	vCC = 5.5 v,	V = 2.7 V			20	μΑ
	A thru H					-0.65	
I _{IL} ‡	S0 or S1	$V_{CC} = 5.5 V,$	V _I = 0.5 V			-1.2	mA
	Any other					-0.6	
los§		$V_{CC} = 5.5 \text{ V},$	V _O = 0	-60		-150	mA
ICC		$V_{CC} = 5.5 \text{ V},$	See Note 2		68	95	mA

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

NOTE 2: ICC is measured with OE1, OE2, and CLK at 4.5 V.

For I/O ports (Q_A thru Q_H), the parameters I_{IH} and I_{IL} include the off-state output current.

[§] Not more than one output shou<u>ld be shorted at a time, and the duration of the short circuit should not exceed one second.</u>

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timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

				V _{CC} =	= 5 V, 25°C	MIN	MAX	UNIT	
				MIN	MAX				
fclock	Clock frequency	0	70	0	70	MHz			
t _W	Pulse duration CLK high or low					7		ns	
t _{su}		S0 or S1	High or low	8.5		8.5			
	Setup time before CLK↑	A/Q _A thru H/Q _H , SR, or SL	High or low	5		5	5 ns		
		CLR	High or low	10		10			
		S0 or S1	High or low	0		0			
th	Hold time after CLK↑	A/Q _A thru H/Q _H , SR, or SL	High or low	2		2		ns	
		CLR	High or low	0		0			

switching characteristics (see Note 3)

PARAMETER	FROM (INPUT)				, F, Ω,	$V_{CC} = 4.5$ $C_L = 50 \text{ pF}$ $R_L = 500 \Omega$ $T_A = \text{MIN t}$	UNIT	
			MIN	TYP	MAX	MIN	MAX	
f _{max}			70	100		70		MHz
^t PLH	CLK	Q _A , or Q _H ,	3.2	6.6	9	3.2	10	ns
^t PHL			2.7	6.1	8.5	2.7	9.5	
^t PLH	CLK	O. thru O.	3.2	6.6	9	3.2	10	ns
^t PHL	CLK	Q _A thru Q _H	4.2	8.1	11	4.2	12	115
^t PZH	OE1 or OE2	O . thru O .	2.7	5.6	8	2.7	9	ns
^t PZL	OET 01 OE2	Q _A thru Q _H	3.2	6.6	10	3.2	11	
^t PHZ	OE1 or OE2	Q _A thru Q _H	1.7	4.1	6	1.7	7	ns
tPLZ	OL 1 OI OLZ	≪A ™™ ≪H	1.2	3.6	5.5	1.2	6.5	110

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. NOTE 3: Load circuits and waveforms are shown in Section 1.



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